

Notice of References Cited	Application/Control No. 10/768,782	Applicant(s)/Patent Under Reexamination R. WU, CHUNG-HSIAO	
	Examiner Viet Q. Nguyen	Art Unit 2827	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0117678	06-2004	Soltis et al.	713/320
	B	US-2004/0162697	08-2004	Smith et al.	702/132
	C	US-2004/0159776	08-2004	Richard et al.	250/214.00R
	D	US-5,881,271	03-1999	Williams, Mark	713/401
	E	US-4,989,256	01-1991	Buckley, Bruce S.	706/41
	F	US-5,623,902	04-1997	Nusser et al.	123/339.16
	G	US-5,710,911	01-1998	Walsh et al.	713/500
	H	US-5,778,425	07-1998	Shigeeda, Akio	711/122
	I	US-5,870,621	02-1999	Walsh et al.	712/32
	J	US-5,987,244	11-1999	Kau et al.	713/500
	K	US-2003/0131160	07-2003	Hampel et al.	710/22
	L	US-4,913,038	04-1990	Burkett et al.	99/331
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.